


<b>Search Notes</b>  	<b>Application/Control No.</b>  10665560	<b>Applicant(s)/Patent Under Reexamination</b>  PARKINS ET AL.
	<b>Examiner</b>  Nguyen, Tran N	<b>Art Unit</b>  3626

SEARCHED			
Class	Subclass	Date	Examiner
705	2	11/13/2007	/TN/

SEARCH NOTES		
Search Notes	Date	Examiner
Continuity search (PALM)	11/13/2007	/TN/
Inventor search (PALM)	11/13/2007	/TN/
US patents (EAST)	11/13/2007	/TN/
NPL (Google/Google Scholar)	11/13/2007	/TN/
US patents (EAST)	8/3/2008	/TN/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner